TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSII)

# **TPC8003**

Lithium Ion Battery Applications Portable Equipment Applications Notebook PC Applications

• Small footprint due to small and thin package

• Low drain–source ON resistance : RDS (ON) = 5.4 m $\Omega$  (typ.)

 $\bullet~$  High forward transfer admittance :  $|\,Y_{fs}\,|\,$  = 21 S (typ.)

• Low leakage current :  $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$ 

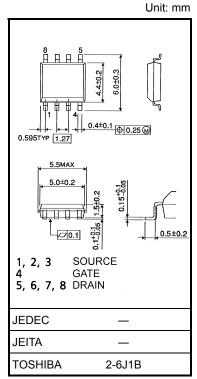
• Enhancement mode :  $V_{th} = 0.8 \sim 2.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

### **Maximum Ratings (Ta = 25°C)**

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	30	V	
Drain-gate voltage (F	R <sub>GS</sub> = 20 kΩ)	$V_{DGR}$	30	V	
Gate-source voltage		$V_{GSS}$	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	13	Α	
Diam current	Pulse (Note 1)	$I_{DP}$	52		
Drain power dissipati	on (t = 10 s) (Note 2a)	$P_{D}$	2.4	W	
Drain power dissipation (t = 10 s) (Note 2b)		$P_{D}$	1.0	W	
Single pulse avalance	he energy (Note 3)	E <sub>AS</sub>	220	mJ	
Avalanche current		I <sub>AR</sub>	13	Α	
Repetitive avalanche (	energy Note 2a) (Note 4)	E <sub>AR</sub>	0.24	mJ	
Channel temperature	;	T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	-55 to 150	°C	

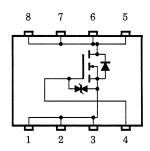
Note 1, Note 2, Note 3 and Note 4: See the next page.

This transistor is an electrostatic-sensitive device. Please handle with caution.



Weight: 0.080 g (typ.)

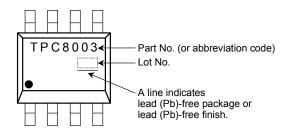
## **Circuit Configuration**



#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	52.1	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	125	°C/W

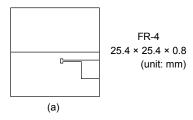
## Marking (Note 5)

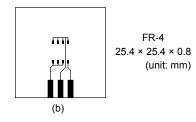


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



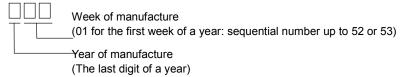


Note 3:  $V_{DD}$  = 24 V,  $T_{ch}$  = 25°C (initial), L = 1.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 13 A

Note 4: Reptitve rating: pulse width limited by maximum channel temperature

Note 5: ● on lower left of the marking indicates Pin 1.

Weekly code: (Three digits)



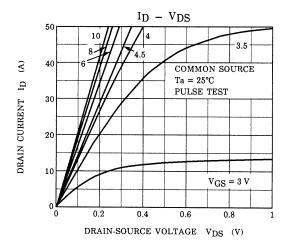
# Electrical Characteristics (Ta = 25°C)

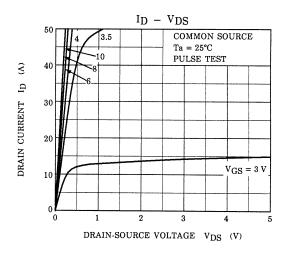
Chara	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μA
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V		_	10	μΑ
Drain-source breakdown voltage		V <sub>(BR) DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	30	_	_	V
		V (BR) DSX	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = -20 V	15	_	_	V
Gate threshold	voltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	0.8	_	2.5	V
Drain-source ON resistance		R <sub>DS (ON)</sub>	V <sub>GS</sub> = 4 V, I <sub>D</sub> = 6.5 A	_	8.3	13	mΩ
		R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.5 A	_	5.4	7	mΩ
Forward transfe	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 6.5 A	10.5	21	_	S
Input capacitano	ce	C <sub>iss</sub>			4380	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	500	_	pF
Output capacitance		Coss		_	890	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10 \text{ V}}{_{0 \text{ V}}} \stackrel{I_{D} = 6.5 \text{ A}}{\underset{\text{V}}{_{OUT}}} \\ V_{CS} \stackrel{\text{O}}{_{0 \text{ V}}} \stackrel{\text{O}}{\underset{\text{V}}{_{100}}} = 15 \text{ V}$ $V_{DD} = 15 \text{ V}$ $Duty \leq 1\%, t_{W} = 10 \mu \text{s}$	_	14	_	
	Turn-on time	t <sub>on</sub>		l	27	ı	ns
	Fall time	t <sub>f</sub>		-	72	_	115
	Turn-off time	t <sub>off</sub>		_	235	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	90		_
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 24 \text{ V, } V_{GS} = 10 \text{ V, } I_D = 13 \text{ A}$	_	60	_	nC
Gate-drain ("miller") charge		$Q_{gd}$			30	_	

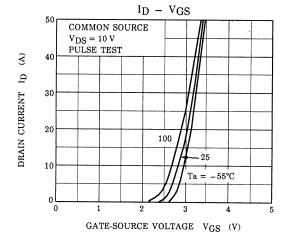
# Source-Drain Ratings and Characteristics (Ta = 25°C)

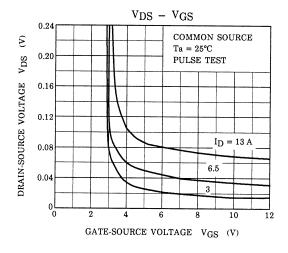
Charact	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	_	_	_	52	Α
Forward voltage (diode)		V <sub>DSF</sub>	I <sub>DR</sub> = 13 A, V <sub>GS</sub> = 0 V	_	_	-1.2	V

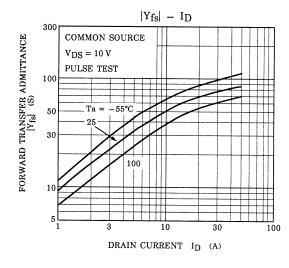
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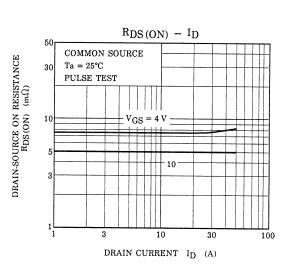




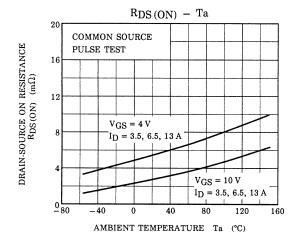


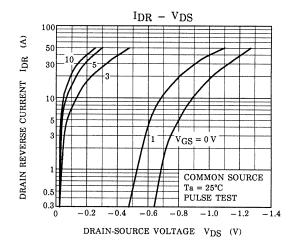


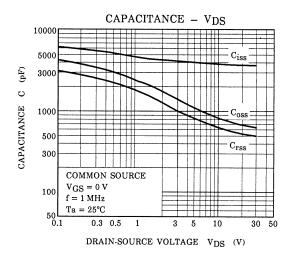


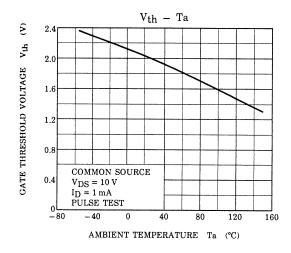


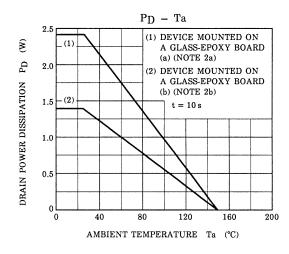
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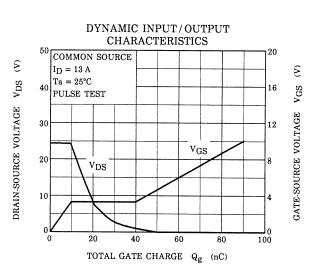


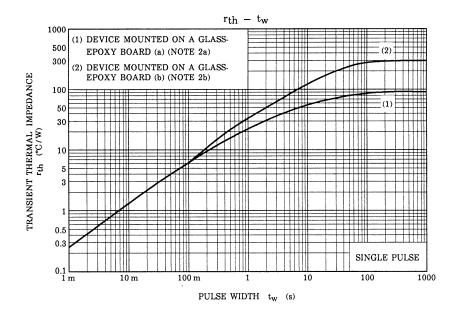


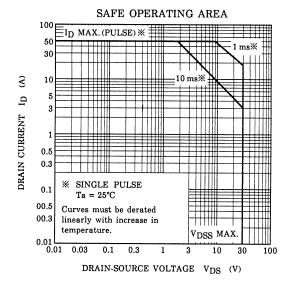


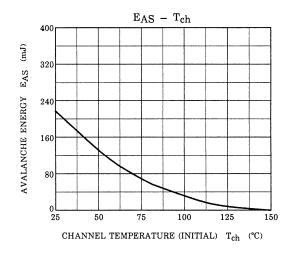


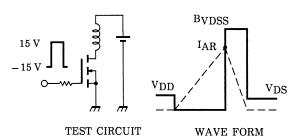












$$\begin{array}{l} T_{ch} = 25^{\circ}\text{C (Initial)} \\ \text{Peak I}_{AR} = 13 \text{ A, R}_{G} = 25 \, \Omega \end{array} \quad E_{AS} = \frac{1}{2} \cdot L \cdot I^{2} \cdot ( \, \frac{\text{BVDSS}}{\text{BVDSS} - \text{VDD}} ) \\ \text{VDD} = 24 \, \text{V, L} = 1.0 \, \text{mH} \end{array}$$

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